nterfacing the LM12458 Data Acquisition System to the MC68HC11AX Microcontroller AN-94

Interfacing the LM12458 Data Acquisition System to the MC68HC11AX Microcontroller

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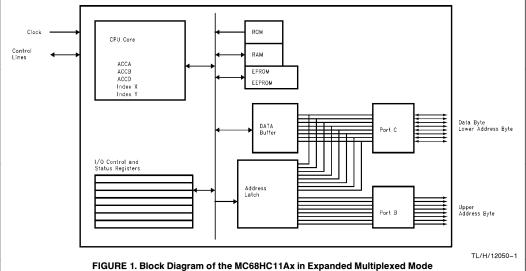
1.0 INTRODUCTION

This application note shows how to interface Motorola's MC68HC11 family of microcontrollers to the LM12458 parallel data acquisition system (DAS). It is intended to give the reader a better understanding of the DAS and how it can be integrated in a $\mu P/\mu C$ system. There is a brief description of the MC68HC11Ax and the LM12458. An example is provided that will illustrate how to use the DAS in a system where a specific sampling rate is desired, single-ended and differential measurements of multiple channels need to be made, and alarm conditions must be monitored. The application note provides a detailed circuit schematic showing the interface circuitry of the DAS to the 68HC11 accompanied with the appropriate assembly code necessary to program the DAS to fulfill the specific requirements of the example.

2.0 GENERAL OVERVIEW OF THE MC68HC11AX AND THE LM12458 DAS

2.1 MC68HC11Ax

The 68HC11 is an 8-bit microcontroller with a 16-bit address range. It has two user modes of operation: single-chip and expanded-multiplexed mode. In single-chip mode, the 68HC11 has no external data bus or address bus. It communicates with external peripherals using its I/O ports. In expanded-multiplexed mode, the 68HC11 uses its 8-bit I/O ports B and C as address and data buses. Port B is the upper address byte. The lower address byte and the data bus are multiplexed together on port C. An address strobe (AS) generated by the 68HC11 indicates when the lower address byte is on port C. This signal may be used with external latches to demultiplex the lower address byte and data bus. In a read or write cycle the address is first placed on ports B and C and the AS is asserted. After a certain time period has elapsed, data is placed on port C. Refer to the manual of the 68HC11 for detailed timing diagrams. The 68HC11 has a R/W control signal that indicates the direction of data flow with respect to the μ C. This signal in conjunction with the E clock may be used to generate read (RD) and write (WR) signals going to the DAS and other peripherals. The 68HC11 has two 8-bit accumulators, ACCA and ACCB and a 16-bit accumulator ACCD that are used for manipulating data. ACCD is a cascade of ACCA and ACCB. When using ACCD to read from or write to memory, data is not transferred in a single 16-bit word but a succession of two 8-bit bytes. Data is first transferred via ACCA, followed by ACCB. Figure 1 shows a block diagram of the MC68HC11Ax in expanded multiplexed mode.



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2.2 LM12458 DAS

The LM12458 is a 12-bit + sign parallel ADC that has an Instruction RAM, Configuration register, FIFO, Timer register, Interrupt Enable and Status register, watchdog detection circuitry, and an eight channel fully differential multiplexer. The DAS has three modes of operation: 12-bit + sign conversion, 8-bit + sign conversion and an 8-bit watchdog comparison mode.

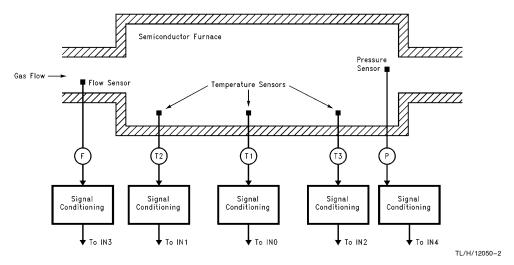
The Instruction RAM has eight 48-bit wide programmable instruction registers (INSTR0-INSTR7). These instructions are used to set the mode of the DAS, the acquisition time, channels that are to be converted and the watchdog limits. The watchdog detects when a particular channel has passed a programmed limit set in the Instruction RAM. Refer to section 2.1 of the data sheet for a detailed description of the Instruction RAM and the watchdog feature. The MUX channel assignments are also set in the Instruction RAM. Table I in section 2.3 of the data sheet gives the MUX address channel assignments. The Configuration register is the control "panel" of the DAS. Its bits start/stop instruction execution, reset the DAS, perform a full calibration and

auto-zero. Refer to section 2.2 of the data sheet for a detailed description of the configuration register. The FIFO has thirty-two 16-bit wide locations. The FIFO stores the conversion data performed by the ADC. Refer to section 3.0 of the data sheet for a detailed description of the FIFO. The DAS has an internal Timer used to delay execution of an instruction by a related amount of clock cycles programmed in the Timer register. Refer to section 2.7 of the data sheet for a detailed description of the timer. The Interrupt Enable register can set up eight different sources that will cause interrupts to occur and the Interrupt Status register indicates the sources of these interrupts. Refer to section 2.4 of the data sheet for a detailed description of the Interrupt Enable register and the Interrupt Status register.

3.0 SYSTEM EXAMPLE

3.1 Furnace Description and System Requirements

A high temperature semiconductor furnace will be the source of the analog signals going to the inputs of the DAS. Refer to Figure 2 for a detailed setup of the furnace and the signals from the furnace that need to be digitized.



Single Ended 0V-2.5V Signals to the DAS Inputs

FIGURE 2. Signal Measurement Arrangements of the Semiconductor Furnace

The DAS will measure:

- T1 at IN0 with 12-bit resolution. (single-ended)
- T1-T2 with 12-bit + sign resolution. T2 is connected to IN1. (differential)
- T1-T3 with 12-bit + sign resolution. T3 is connected to IN2. (differential)
- The gas flow, F at IN3 with 8-bit resolution and an extended acquisition. (single-ended)
- The pressure, P at IN4 with 8-bit resolution. (single-ended)

The DAS will also be used to monitor three alarm conditions.

- Gas flow, F exceeds a maximum limit.
- · Gas flow, F falls below a minimum limit.
- Pressure, P exceeds a maximum limit.

The following assumptions are made about the furnace system:

- All the analog signals to be measured by the DAS are conditioned so that their voltage levels are within the range 0V-2.5V.
- \bullet The output of the flow sensor signal conditioning circuit has a 600 Ω source impedance.
- The DAS reference voltage is 2.5V. (V_{REF}+ = 2.5V and V_{REF}- = AGND)
- The DAS is to achieve a throughput rate of 50 Hz per signal measured.

The DAS will be programmed as follows:

Seven instructions, INSTR0 through INSTR6 of the Instruction RAM will be used.

INSTR0: Watchdog mode for the gas flow, F, with the acquisition factor D=1. The timer bit is also set.

INSTR1: Watchdog mode for the gas pressure P.

INSTR2: Measure T1 at IN0 with 12-bit resolution. $V_{IN}+=$ IN0 and $V_{IN}-=$ AGND.

INTSR3: Measure T1-T2 with 12-bit + sign resolution. T2 is connected to IN1. $V_{IN}+=$ IN0 and $V_{IN}-=$ IN1.

INSTR4: Measure T1-T3 with 12-bit + sign resolution. T3 is connected to IN2. $\rm V_{IN}+=IN0$ and $\rm V_{IN}-=IN2.$

INSTR5: Measure the gas flow, F at IN3 with 8-bit resolution and the acquisition factor D = 1. V_{IN} + = IN3 and V_{IN} - = AGND.

INSTR6: Measure the pressure, P at IN4 with 8-bit resolution. $V_{IN}+=$ IN4 and $V_{IN}-=$ AGND.

- The DAS loops back to INSTR0 after executing INSTR6. Each loop is called an instruction loop.
- Each instruction loop generates five conversion results. The DAS is programmed to interrupt the 68HC11 when the FIFO has five conversions stored in it. This interrupt will occur after execution of INSTR6 in every instruction loop at which time the FIFO will be read by the 68HC11.
- The DAS will not be stopped when the FIFO is read. The FIFO is read during the time delay added between INSTR6 and INSTR0.

Since the flow sensor circuitry has an output impedance of 600 Ω , it requires additional acquisition time. From the data sheet, the acquisition factor D in 8-bit mode is:

$$D = 0.36 * R_S * f_{CLK}$$

D = 0.36 * 0.600 * 5 = 1.08

D = 1

Ac	p14 D13 equisition Time	D12	D11			_		n for RP	- 00						
D15 [equisition Time			D10	D9	D8	D7	D6	D5	D4	D3	D2	D1	D0	
			W-dog	8/12	Timer	Sync		$v_{\text{IN}}-$			$V_{IN}+$		Pause	Loop	
	INSTR0: Watchdog Mode for Flow, D = 1, Timer Enabled $V_{IN} + = IN3, V_{IN} - = AGND$														
0	D14 D13	D12	D11	D10	D9	D8	D7	D6	D5	D4	D3	D2	D1	D0	
D15 [D14 D13	D12	D11	D10	D9	D8	D7	D6	D5	D4	D3	D2	D1	D0	
0	0 0	0	1	0	0	0	0	0	0	1	0	0	0	0	
INSTR2: Measuring T1, Single-Ended, 12-Bit $ m V_{IN}+=IN0$ (T1), $ m V_{IN}-=AGND$															
D15 [D14 D13	D12	D11	D10	D9	D8	D7	D6	D5	D4	D3	D2	D1	DO	
0	0 0	0	0	0	0	0	0	0	0	0	0	0	0	0	
INSTR3: Measuring T1-T2, Differential, 12-Bit + Sign $V_{\text{IN}} + = \text{IN0 (T1), } V_{\text{IN}} - = \text{IN1 (T2)}$															
D15 [D14 D13	D12	D11	D10	D9	D8	D7	D6	D5	D4	D3	D2	D1	D0	
0	0 0	0	0	0	0	0	0	0	1	0	0	0	0	0	
INSTR4: Measuring T1-T3, Single-Ended, 12-Bit + Sign $V_{\text{IN}} + = \text{IN0 (T1) V}_{\text{IN}} - = \text{IN2 (T3)}$															
	D14 D13	D12	D11	D10	D9	D8	D7	D6	D5	D4	D3	D2	D1	D0	
0	0 0	0	0	0	0	0	0	1	0	0	0	0	0	0	
INSTR5: Measuring Flow, Single-Ended, 8-Bit, D $=$ 1 $V_{IN}+=$ IN3, $V_{IN}-=$ AGND															
D15 [D14 D13	D12	D11	D10	D9	D8	D7	D6	D5	D4	D3	D2	D1	D0	
0	0 0	1	0	1	0	0	0	0	0	0	1	1	0	0	
INSTR6: Measuring Pressure, Single-Ended, 8-Bit, Loop Bit Set $V_{\rm IN}+={ m IN4,}V_{\rm IN}-={ m AGND}$															
D15 [D14 D13	D12	D11	D10	D9	D8	D7	D6	D5	D4	D3	D2	D1	D0	
0	0 0	0	0	1	0	0	0	0	0	1	0	0	0	1	

D15	D14	D13	D12	D11	D10	D		D8	, Limits	D6	D5	D4	D3	D2	D1	D0
		Don't				+	′<	Sign					Limit			
						ı.	ICTE	20 lim	it #1, RF	2 – 01						
D15	D14	D13	D12	D11	D10			D8	D7	D6	D5	D4	D3	D2	D1	D0
0	0	0	0	0	0	١.	ı	0		1	-1	Fl	ow_Max			
						IN.	ISTE	30. Lim	it #2, RF	P = 10						
D15	D14	D13	D12	D11	D10	D		D8	D7	D6	D5	D4	D3	D2	D1	D0
0	0	0	0	0	0	()	0				FI	ow_Min			
						IN	ISTF	R1, Lim	it #1, RF	P = 01						
D15	D14	D13	D12	D11	D10	D	9	D8	D7	D6	D5	D4	D3	D2	D1	D0
0	0	0	0	0	0		I	0				Pr	es_Max			
INSTR1, Limit #2, RP = 10																
D15	D14	D13	D12	D11	D10	D	9	D8	D7	D6	D5	D4	D3	D2	D1	D0
0	0	0	0	0	0	()	0				Pi	es_Min			
					li	nterri	ıpt E	Enable	Register	Definit	ion					
D15	D14	D13	D12	D11	D10	D9		D8	D7	D6	D5	D4	D3	D2	D1	D0
	Number	of Results i	n FIFO		Instru	uction N	lumb	er	INT7	INT6	INT5	INT4	INT3	INT2	INT1	INT0
			Wato	hdog L	imit, FII	FO Fu	II (C	onv =	5), and <i>i</i>	Auto-Ze	ro Inte	rrupts E	nabled			
D15	D14	D13	D12	D11	D10	D	9	D8	D7	D6	D5	D4	D3	D2	D1	D0
0	0	1	0	1	0	()	0	0	0	0	1	0	1	0	1
						Conf	igur	ation R	egister l	Definition	on					
D15	D14 D	13 D12	D11	D10	D9	D8	- 1	D7	D6	D!	5	D4	D3	D2	D1	D0
	Don't Ca	re	Diag	Test	RAM Pointe		Syn	nc I/O	A/Z Each	Chan I	Mask	Standby	Full Cal	Auto Zero	Reset	Star
								- 4 04 -				00.4				
D15	D14	D13	D12	D11	D10	tion F	_	D8	rt Comn	D6	D5	D4	D3	D2	D1	D0
0	0	0	0	0	0			0	1	0	0	0	0	0	0	1
	•				Co	nficu	atio	n Reci	ster Res	et Com	mand			•		
D15	D14	D13	D12	D11	D10			D8	D7	D6	D5	D4	D3	D2	D1	D0
0	0	0	0	0	0	(0	0	0	0	0	0	0	1	0
	•	· '			Configu	ratio	n Pa	nieter	Full Calil	ration	Comm	and	•		'	
D15	D14	D13	D12	D11	D10	D		D8	D7	D6	D5	D4	D3	D2	D1	D0
	0	0	0	0	0	1 ,)	0	0	0	0	0	1	0	0	0

3.3 Determining the Throughput Rate

The following table gives the number of clock cycles each instruction takes to execute. The total number of clock cycles may then be used to determine how long it will take for all the instructions to be executed. This will aid in calculating the throughput rate of the DAS.

Instruction State 0		State 1	State 7	State 6	State 4	State 5	Clock Cycles		
0	1	1	9			44	55		
1	1	1	9			44	55		
2	1	1	9			44	55		
3	1	1	6			21	29		
4	1	1	2			21	25		
5	1	1	6	5	1	5	19		
6	1	1	2	5	1	5	15		
	•					Total	253		

Since the timer will be used, an additional 2 clock cycles need to be added to the total 253.

The total time it takes to execute a full instruction loop with a clock frequency (f_{CLK}) of 5 MHz is:

$$(253 + 2) * 200 \text{ ns} = 51 \mu \text{s}$$

In addition to the instruction loop execution time, there is some delay time added at the end of the instruction loop for each chip select made to the DAS when reading the five conversions stored in the FIFO. Whenever chip select is asserted, all clock dependent activities of the DAS come to a halt. This delay is the total amount of time that chip select has gone low when reading the FIFO. Each chip select cycle is 500 ns long (refer to the timing diagrams). There are five conversions, two bytes each, that will be read. This gives a total of ten chip selects (one chip select per byte). Ten chip selects at 500 ns per chip select gives a total delay time of 5 us, so the time required to complete an instruction loop and read the conversion results is 51 μ s + 5 μ s = 56 μ s. The desired throughput rate is 50 Hz (a sample per channel every 20 ms). This implies that a delay time between instruction loops must be added. The delay time is equal to:

$$20 \text{ ms} - 56 \mu \text{s} = 19.944 \text{ ms}$$

This time delay may be inserted between instruction loops by setting the timer bit in INSTR0. The amount of the time delay is related to the value stored in the timer register. The following shows how to calculate the value to put in the timer register to give a delay of 19.944 ms:

The number of 5 MHz clock cycles in 19.944 ms is: 19.944 ms * 5 MHz = 99720 clock cycles

The timer increments every 2⁵ (32) clock cycles. Therefore, the value to be placed in the timer register is:

99720/32 = (3116.25)_{base10} = (**0C2C**)_{base16}

The 0.25 fraction is lost when converting (3116.25) $_{base10}$ to hexadecimal. This results in decreasing the delay time by eight 5 MHz clock cycles (8*200~ns= **1.6** μs) to 19.9424 ms. So the actual throughput rate is:

19.9424 ms + 56 $\mu s =$ 19.9984 ms

 $\frac{1}{19.9984 \text{ ms}} = 50.004 \text{ Hz}$

4.0 SYSTEM OVERVIEW

4.1 How to Communicate with the DAS

In developing the software and circuitry to program the DAS for the furnace example, Motorola's EVM development system for emulating the MC68HC11A8 was used. In this application note it is assumed that the reader is already familiar with the architecture and instruction set of the MC68HC11A8. The reader should also be familiar with the LM12(H)454/8 DAS by having previously read the data sheet. In this design the $\mu\text{C's}$ E_{clock} is 2 MHz and the DAS clock is running at 5 MHz.

The DAS can be selected to run on an 8-bit or a 16-bit data bus. Since we are using an 8-bit μC the DAS must be configured to operate in 8-bit mode. This is done by hardwiring the "BW" pin to a logic 1. The internal registers of the DAS are all 16 bits long, so in order to read from and write to a 16-bit register while in 8-bit mode, data transfer must take place in two cycles. In fact when in 8-bit mode the internal registers are byte addressable. The 68HC11 architecture and instruction set facilitates this transfer of data in two ways. One way is using standard 8-bit reads and writes via the 8-bit accumulators. For example, a 16-bit write to the configuration register:

LDAA #DATAl ;DATAl is the least significant ;byte (LSB).

STAA CONFIG1 ; CONFIG1 = Address of LSB of ; the configuration register.

LDAA #DATA2 ;DATA2 is the most significant ;byte (MSB).

STAA CONFIG2 ; CONFIG2 = Address of MSB of ; the configuration register.

Notice that it takes 4 instructions to do this.

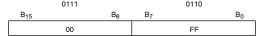
Another way of achieving the same results with half the number of instructions is to use the 68HC11's 16-bit double accumulator D. This accumulator is an actual cascading of ACCA and ACCB. ACCA is the most significant byte of ACCD and ACCB is the least significant byte.

B ₁₅		CCD	B ₀
	ACCA	ACCB	

When using ACCD the instruction set emulates that of a 16-bit processor. The above example becomes:

LDD #DATA ;DATA is 16 bits.
STD CONFIG ;Address of configuration ;register.

This is not a true single 16-bit transfer of data but a succession of 8-bit ones. When using ACCD the user should notice that data is first transferred from ACCA followed by data from ACCB. This plays an important role in determining the data that is sent to and received from the DAS. To demonstrate this let's look at an example that will write #00FFh to the configuration register located at address 0110h. The lower byte at address 0110h should receive #FFh and the upper byte at address 0111h should receive #00h as shown below:



Configuration Register (Desired Result)

The most intuitive way to do this is:

LDD #00FFh STD 0110h

but this will result in:



Configuration Register (Wrong Approach)

This routine is incorrect because the high-byte (#00h) is written to address 0110h instead of 0111h and the low-byte (#FFh) is written to address 0111h instead of 0110h. The reason for this is that the contents of ACCA are written first followed by those of ACCB. The correct way to do this is to swap the two bytes in the first instruction when writing the code.

LDD #FF00h STD 0110h resulting in:

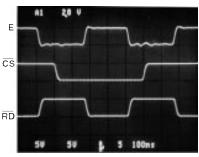


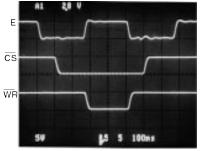
Configuration Register (Correct Approach)

When using ACCD to write data to the DAS, make sure that the ACCD's upper-byte contains the data's lower-byte and its lower-byte contains the data's high-byte. Using ACCD to read from the FIFO and store data in memory results in having the upper and lower bytes of the converted data swapped. This does not cause any problems if the data from memory is interpreted correctly. However, if the user does not want to store the data in this swapped format, ACCD should not be used to write to memory. After the data has been read from the FIFO with the ACCD, accumulators A and B should be used to write the data to memory, not ACCD. Specifically, the data in ACCB should be written to the lower address in memory and the contents of ACCA to the higher address. Now when ACCD is used to read conversion results that are stored in memory, it will have the upper and lower bytes of the data in a more logical format.

4.2 Hardware Description of the Interface Circuitry

The DAS (U7) is seen by the 68HC11 (U1) (Refer to Figure 4) as an I/O device placed at a certain location in memory. The interface consists of standard address decoding circuitry using U2, U3, and U4 and demultiplexing of the R/\overline{W} signal line with U5 and U6. U2 is an 8-bit latch that is used to demultiplex the lower address byte from the data byte by using the address strobe signal AS. U4 is an 8-bit comparator that compares the upper address byte to the 8-bit value preset by S1. The value set by S1 determines what upper address byte the DAS is placed at. In this example it is set to 01h. The output of U4 enables U3, U3 is a three bit decoder used to generate the chip select of the DAS. ICs U5 and U6 create the RD and WR signals to the DAS. Refer to Figure 3 for the timing diagrams of a read and write cycle. Jumpers J1 and J2 connect the $V_{ref}+$ and $V_{ref}-$ of the DAS to an external source or the on-board 5V supply. Header HDR1 connects the analog inputs to the DAS. The filter capacitors used for VA+, VD+, V_{ref}+ V_{ref}-, and V_{refout} should be as close to their respective pins as possible. Refer to section 5.0 of the data sheet for power supply and ground considerations.





TL/H/12050-3

TL/H/12050-4

FIGURE 3. Timing Diagrams Showing the E Clock, $\overline{\text{CS}}$, $\overline{\text{RD}}$ and $\overline{\text{WR}}$ Signals

The signals in $\it Figure~3$ were generated by executing the following program:

Loop LDAA \$0100 ;Reads the DAS
STAA \$0100 ;Writes to the DAS
BRA Loop

In order to access all the DAS registers, at least twenty seven consecutive memory locations are needed. In this particular example the DAS is placed at address locations 0100h to 011Fh. This address range allows all the DAS registers to be accessed, which are located at addresses 0100h to 011Bh. (Refer to the data sheet for specific addresses of registers.) By selecting the appropriate settings on the dip switch S1, the user can choose the upper address byte the DAS is placed at.

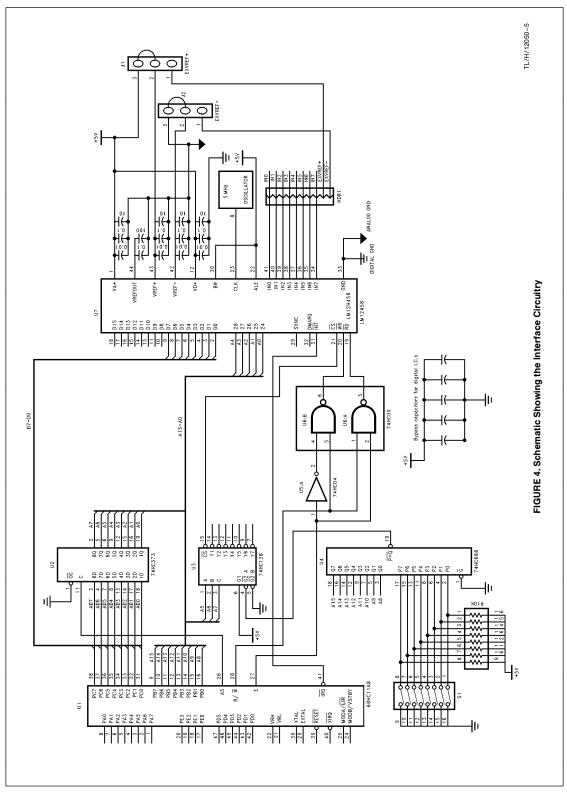
4.3 Description of the Software

In the first part of the program (Figure 5), the DAS is initialized to meet the specifications needed for the furnace example. After the DAS has been initialized and a full auto-calibration is completed, the DAS is reset and instruction execution is started by writing a logic one in the configuration's start bit. The 68HC11 waits for an interrupt. When an interrupt is generated by the DAS, program execution jumps to the interrupt service subroutine. The actions taken by the interrupt service routine are based on which interrupt bits are set in the Interrupt Status Register. The FIFO_FUL interrupt is the only interrupt that is fully serviced by this program. It is important to note that the Interrupt Status register should not be polled because every time \overline{CS} is pulled low all internal clock-dependent activities of the DAS stop, e.g. the A/D converter, sequencer and timer. Conditions that need to be serviced must be done on an interrupt basis

When a FIFO full interrupt occurs, the DAS is programmed to empty the five conversions stored in the FIFO starting at the address pointed to by the conversion pointer CONV_POINT. The CONV_POINT holds the address of where data is to begin being stored in memory. In this example, the conversion pointer is initialized to point to ad-

dress 00h. After reading the five conversions stored in the FIFO and putting them in memory, program execution resumes at the main program following the WAI instruction. This 68HC11 instruction puts the μC in an idle state and waits for an interrupt to occur, at which time program execution will jump to the interrupt service routine. Index register X counts the number of data bytes read from the FIFO and stored in memory. It is also used as an offset to the CONV_POINT to give the address of where the data byte read from the FIFO is to be stored. The value in X is compared against the value CONV_BYTES. When it is greater than CONV_BYTES, program execution is halted. If it is less than CONV_BYTES, the 68HC11 jumps back to the WAI instruction and waits for another FIFO full interrupt to occur. In this example CONV_BYTES is equal to sixty. Since the circuit that was used for this example contains no external memory, the on board microcontroller RAM was used. If external memory is needed the software and board can be easily modified. A memory component can be placed at a certain location in the memory map by using one of the seven available signals from the 74H138 to generate the chip select. The conversion pointer, CONV_POINT needs to be initialized with the beginning address of where converted data is to be stored in memory and CONV_BYTES needs to be set to twice the desired number of conversions. For example, if 8192 samples are to be taken and are to begin being stored at address 1000h, CONV_BYTES should be set to 16384 CONV_POINT to 1000h.

The DAS_LIMIT interrupt subroutine is intended to service watchdog conditions. In this furnace example no provisions have been made to deal with a watchdog interrupt except that of acknowledging its occurrence and returning to the main program. The manner in which a watchdog condition is handled is system-dependent and must be user-defined. The purpose of the FUL_CAL subroutine is to indicate when the DAS has completed its full auto-calibration cycle. The only action taken in the FUL_CAL interrupt subroutine is a return to the main program.



INSTRA INSTRA INSTRA EQU \$0100 INSTRA EQU \$0104 INSTRA EQU \$0106 INSTRA EQU \$01010 INT_STAT EQU \$01012 INT_STAT EQU \$01112 INT_STAT EQU \$01114 INT_STAT EQU \$0116 INT_STAT INT_STAT EQU \$0116 INT_STAT INT	**************************************	* ************************************	
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LDD #\$2000 LDD #\$6024 LDD #\$6020 LDD #\$71MER_SFT Limit #1. LDD #\$71MER_SFT Limit #1. LDD #\$71MER_SFT Limit #1. LDD #\$71MER_SFT LDD #\$71MER_S	LDD #\$1008 STD INSTR1	Instruction 1 used to set watchdog mode for pressure measurements.
#\$2000 Instruction 3 measures T1-T2 in 12-bit + sign mode INSTRA T2 is at IN1. #\$4000 Instruction 4 measures T1-T3 in 8-bit mode. INSTR4 T3 is at IN2 #\$6024 Instruction 5 measures gas flow in 8-bit mode INSTR5 at IN3 with an acquisition delay time set (D=2). #1104 Instruction 6 measures pressure in 8-bit mode INSTR6 at IN4. #\$1001 Sets the RAM Pointer to 01. CONFIG WFLOW_MAX Sets the watchdog upper limit for maximum pressure. INSTR1 Limit #1. #\$1002 Sets the watchdog upper limit for maximum pressure. INSTR1 Limit #1. #\$1002 Sets the lower watchdog flow limit. INSTR1 Sets the lower watchdog pressure limit. INSTR1 Sets the lower watchdog pressure limit. #\$13128 Enabling FIFO full (=5 CONV.), watchdog and INT_EN auto-cal interrupts. UNE 5.68HC11Assembly Program Listing (Confined)	LDD #\$0000 STD INSTR2	single-ended in 12-bit + sign mode.
#\$4000 Instruction 4 measures T1-T3 in 8-bit mode. INSTR4 #\$6024 Instruction 5 measures gas flow in 8-bit mode at IN3 with an acquisition delay time set (D=2). #1104 Instruction 6 measures pressure in 8-bit mode at IN4. #108TR6 #\$1001 Sets the RAM Pointer to 01. #CONFIG #FLOW_MAX Sets the watchdog upper limit for maximum flow. INSTR0 Limit #1. #0002 CONFIG #FLOW_MIN Sets the NAM Pointer to 10. #ONE Sets the lower watchdog flow limit. INSTR1 #FLOW_MIN Sets the lower watchdog pressure limit. INSTR1 #TIMER_SET FORT Configures the timer to a preset value so that a 50Hz throughput rate is achieved. #TIMER_SET Configures the timer to a preset value so that a 30Hz throughput rate is achieved. ##1328 ##1328 Bnabling FIFO full (=5 CONV.), watchdog and auto-cal interrupts. UNE 5.68HC11 Assembly Program Listing (Continued)		truction 3 measures T1-T2 in 12-bit \pm is at IN1.
#\$6024 Instruction 5 measures gas flow in 8-bit mode at INSTR5 #1104 Instruction 6 measures pressure in 8-bit mode at IN4. #1104 Instruction 6 measures pressure in 8-bit mode at IN4. #\$6001 Sets the RAM Pointer to 01. CONFIG #FLOW_MAX Sets the watchdog upper limit for maximum flow. Limit #1. #PRES_MAX Limit #1. #PRES_MAX Sets the watchdog upper limit for maximum pressure. Limit #1. #PRES_MAX Sets the watchdog upper limit for maximum pressure. Sets the watchdog upper limit for maximum pressure. INSTR1 #PRES_MAX Limit #1. #TROW_MIN Sets the lower watchdog flow limit. #FLOW_MIN Sets the lower watchdog pressure limit. #TIMER_SET Configures the timer to a preset value so that a 50Hz throughput rate is achieved. #\$1328 Enabling FIFO full (=5 CONV.), watchdog and auto-cal interrupts. UNE 5.68HC11 Assembly Program Listing (Continued).		truction 4 measures T1-T3 in is at IN2
#1104 at Instruction 6 measures pressure in 8-bit mode #\$1001 #\$20001 Sets the RAM Pointer to 01. #PLOW_MAX Inmit #1. #PRES_MAX Sets the watchdog upper limit for maximum flow. INSTR1 #PRES_MAX Sets the watchdog upper limit for maximum pressure. #NO02 CONFIG #FLOW_MIN Sets the lower watchdog flow limit. #PRES_MIN #PRES_MIN #PRES_MIN #TIMER_SET Configures the timer to a preset value so that a 50Hz throughput rate is achieved. #\$1328 ##\$1328 ##\$1328 ##\$1328 ##\$1328 ##\$1328 ##\$1328 ##\$1328 ##\$1328 ##\$1338 ##\$1344 ##\$1344 ##\$1444 ##\$1444 ##\$1544 ##\$1544 ##\$1544 ##\$1544 ##\$1545 ##\$1544 ##\$1544 ##\$1544 ##\$1544 ##\$1544 ##\$1544 ##\$1544 ##\$1544 ##\$1544 ##\$1545 ##\$1544 ##\$1545 ##\$1545 ##\$1545 ##\$1545 ##\$1545 ##\$1545 ##\$1545 ##\$1545 ##\$1545 ##\$1545 ##\$1545 ##\$1545 ##\$1545 ##\$1545 ##\$155 ##\$155 ##\$156 ##\$156 ##\$166		
#\$LOW_MAX Sets the watchdog upper limit for maximum flow. INSTRO #FLOW_MAX Sets the watchdog upper limit for maximum flow. Limit #1. #PRES_MAX Sets the watchdog upper limit for maximum pressure. Limit #1. #PRES_MAX Sets the watchdog upper limit for maximum pressure. Limit #1. #PRES_MAX Sets the RAM Pointer to 10. CONFIG Sets the lower watchdog flow limit. INSTRO #PRES_MIN Sets the lower watchdog pressure limit. #TIMER_SET Configures the timer to a preset value so that a 50Hz throughput rate is achieved. #\$1328 Enabling FIFO full (=5 CONV.), watchdog and auto-cal interrupts. UNE 5.68HC11 Assembly Program Listing (Continued)		6 measures pressure
#FLOW_MAX Sets the watchdog upper limit for maximum flow. Limit #1. #PRES_MAX Limit #1. #PRES_MAX Sets the watchdog upper limit for maximum pressure. Limit #1. #O002 Sets the RAM Pointer to 10. #CONFIG #FLOW_MIN Sets the lower watchdog flow limit. #PRES_MIN Sets the lower watchdog pressure limit. #TIMER_SET Configures the timer to a preset value so that a 50Hz throughput rate is achieved. #\$1328 Enabling FIFO full (=5 CONV.), watchdog and auto-cal interrupts. UNE 5.68HC11 Assembly Program Listing (Continued)		the RAM Pointer to
#PRES_MAX Sets the watchdog upper limit for maximum pressure. Instraction Limit #1. #0002 CONFIG #FLOW_MIN Sets the lower watchdog flow limit. INSTRO #PRES_MIN Sets the lower watchdog pressure limit. INSTR1 #TIMER_SET Configures the timer to a preset value so that a 50Hz throughput rate is achieved. #\$1328		watchdog upper limit
#FLOW_MIN Sets the lower watchdog flow limit. INSTRO #PRES_MIN Sets the lower watchdog pressure limit. INSTR1 #TIMER_SET Configures the timer to a preset value so that a 50Hz throughput rate is achieved. #\$1328 Enabling FIFO full (=5 CONV.), watchdog and INT_EN auto-cal interrupts. UNE 5.68HC11 Assembly Program Listing (Continued)		
#FLOW_MIN Sets the lower watchdog flow limit. INSTRO #PRES_MIN Sets the lower watchdog pressure limit. INSTR1 #TIMER_SET Configures the timer to a preset value so that a 50Hz throughput rate is achieved. #\$1328 Enabling FIFO full (=5 CONV.), watchdog and INT_EN auto-cal interrupts. JRE 5.68HC11 Assembly Program Listing (Continued)		the RAM Pointer to
#PRES_MIN Sets the lower watchdog pressure limit. INSTR1 #TIMER_SET Configures the timer to a preset value so that a 50Hz throughput rate is achieved. #\$1328		the lower watchdog
#TIMER_SET Configures the timer to a preset value so that a TIMER 50Hz throughput rate is achieved. #\$1328 Enabling FIFO full (=5 CONV.), watchdog and INT_EN auto-cal interrupts.	LDD #PRES_MIN STD INSTR1	the lower watchdog pressure
#\$1328 Enabling FIFO full (=5 CONV.), watchdog and INT_EN auto-cal interrupts. JRE 5, 68HC11 Assembly Program Listing (Continued)		Configures the timer to a preset value so that 50Hz throughput rate is achieved.
		<pre>Enabling FIFO full (=5 CONV.), watchdog and auto-cal interrupts.</pre>
	FIGURE 5. 68HC1	

	LDD INT_STAT	Reads interrupt status register to clear it.	
* *	LDD #\$0800 STD CONFIG	Starts a full auto-calibration cycle. An interrupt will be generated when done.	
* * 1	WAI	Waits for interrupt to occur. When an interrupt is generated program control resumes at the interrupt service routine.	
******	* STARIS CONVERSI	STARTS CONVERSION ************************************	
K 4	LDD #\$0200 STD CONFIG	Resets the DAS	
к ж	CLI LDD #\$8100 STD CONFIG	Enables 68HC11 interrupt. Starts conversion with sync out.	
* CONV	WAI	Waits for interrupt to occur. When an interrupt is generated program control resumes at the interrupt service routine.	
к .	CPX #CONV_BYTES BLT CONV STOP	Compares number of conversion bytes (value stored in register X) to decimal number 60. Two bytes per conversion. Program execution is halted.	
******	END OF MAIN PROGRAM	OGRAM ************************************	
* * * * * * * * * * * * * * * * * * * *	INTERRUPT SERVIC	INTERRUPT SERVICE ROUTINE ************************************	
· IRQ	LDAA INT_STAT STAA STAT_HOLD	Reads the lower byte of the interrupt status register and stores the result at address STAT_HOLD.	
· *	LDAA STAT_HOLD ANDA #\$04 BGT FIFO_FUL	Checks bit 2 to determine if FIFO full was the source of the interrupt. If so, continue at ${\tt FIFO_FUL}$ subroutine.	
* *	LDAA STAT_HOLD ANDA #\$01 BGT DAS_LIMIT	Checks bit 0 to determine if watchdog limit was the source of the interrupt. If so, resume program at DAS_LIMIT subroutine.	
	FIG	TL/H7120 FIGURE 5. 68HC11 Assembly Program Listing (Continued)	TL/H/12050-8

					bytes.									TL/H/12050-9
Checks bit 4 to determine if full cal limit caused interrupt. If so, continue program control at Ful_Cal subroutine.		READ_FIFO SUBROUTINE WILL TAKE CONVERSIONS ************************************	Index register Y used as a local counter.	Loads the contents of the FIFO in ACCD and increments	X is used as a global counter and holds the total number of conv bytes.	Socies the result read from the First at address CONV_FOLM! + A. Increments index register X by two for every conversion read. pointer to the next memory location where data is to be stored.	Escape from loop when Y counter exceeds 3.	OF READ_FIFO SUBROUTINE *********************************	DAS_LIMIT SUBROUTINE IS USER DEFINED AND MUST************************************	The user should check to see whether the interrupt was caused by pressure or gas flow exceeding their limits and then act accordingly.	RTI **************END OF DAS_LIMIT SUBROUTINE ************************************	**************************************	INTERRUPT SERVICE ROUTINE ***********************************	FIGURE 5. 68HC11 Assembly Program Listing (Continued)
ANDA #\$10 Che BGT FUL_CAL If	RTI	READ_FIFO SUBROUTIN STORED IN FIFO AND	LDY #\$0000	LDD FIFO	STD CONV_POINT, X	INX INX	INY CPY #\$03 BLE LOOP	RTI END OF READ_FIFO SU	DAS_LIMIT SUBROUTINE TAKE THE APPROPRIATE ARE GENERATED.	The by acc	RTI END OF DAS_LIMIT SU	'FULL-CAL ROUTINE*** RTI **********	END OF	FIGU
* *		* * * * * * * * * * * * * * * * * * *	FIFO_FUL	LOOP		•		RTI ********************END	***********	DAS_LIMIT ** **	*****	* * * * * * * * * * * * * * * * * * *	******	

AN-947 Interfacing the LM12458 Data Acquisition System to the MC68HC11AX Microcontroller

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